



SPECIFICATION

(Reference sheet)

· Supplier : Samsung electro-mechanics · Samsung P/N : CL31A106KOHNNNE

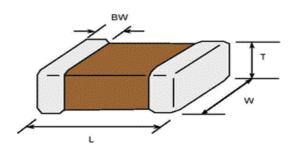
· Product : Multi-layer Ceramic Capacitor · Description : CAP, 10uF, 16V, ±10%, X5R, 1206

A. Samsung Part Number

<u>CL</u> <u>31</u> <u>A</u> <u>106</u> <u>K</u> <u>O</u> <u>H</u> <u>N</u> <u>N</u> <u>N</u> <u>E</u> ① ② ③ ④ ⑤ ⑥ ⑦ ⑧ ⑨ ⑩ ⑪

1	Series	Samsung Multi-layer Ceramic Capacitor						
2	Size	1206 (inch code)	L: $3.20 \pm 0.20 \text{ mm}$		W:	1.60 ± 0.20 mm		
3	Dielectric	X5R	8	Inner electrode		Ni		
4	Capacitance	10 uF		Termination		Cu		
(5)	Capacitance	±10 %		Plating		Sn 100% (Pb Free)		
	tolerance		9	Product		Normal		
6	Rated Voltage	16 V	10	Special		Reserved for future use		
7	Thickness	$1.60 \pm 0.20 \; \text{mm}$	11	Packaging		Embossed Type, 7" reel		

B. Structure & Dimension



Sameung D/N	Dimension(mm)					
Samsung P/N	L	W	Т	BW		
CL31A106KOHNNNE	3.20 ± 0.20	1.60 ± 0.20	1.60 ± 0.20	0.50 ± 0.30		

C. Samsung Reliablility Test and Judgement Condition

Capacitance Within specified tolerance 1kHz ±10% / 1.0±0.2Vrms *A capacitor prior to measuring the ca	-			
Tan δ (DF) 0.1 max. treated at 150 ℃ +0/-10 ℃ for 1 hour an ambient air for 24±2 hours. Insulation 10,000Mohm or 100Mohm×μF Rated Voltage 60~120 sec. Resistance Whichever is smaller Appearance No abnormal exterior appearance Microscope (×10) Withstanding No dielectric breakdown or 250% of the rated voltage	-			
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The delegate product of the factor voltage	Microscope (×10)			
Walterna Incohamical harakatum	250% of the rated voltage			
Voltage mechanical breakdown				
Temperature X5R				
Characteristics (From-55 ℃ to 85 ℃, Capacitance change should be within ±15%)				
Adhesive Strength No peeling shall be occur on the 500g·f, for 10±1 sec.	500g·f, for 10±1 sec.			
of Termination terminal electrode				
Bending Strength Capacitance change: within ±12.5% Bending to the limit (1mm)				
with 1.0mm/sec.				
Solderability More than 75% of terminal surface SnAg3.0Cu0.5 solder				
is to be soldered newly 245±5°C, 3±0.3sec.				
(preheating : 80~120°C for 10~30sec.))			
Resistance to Capacitance change: within ±7.5% Solder pot : 270±5°C, 10±1sec.				
Soldering Heat Tan δ, IR: initial spec.				
Vibration TestCapacitance change : within \pm 5%Amplitude : 1.5mmTan δ, IR : initial spec.From 10Hz to 55Hz (return : 1min.)2hours \times 3 direction (x, y, z)				
Moisture Capacitance change: within ±12.5% With rated voltage				
Resistance Tan δ : 0.125 max 40±2℃, 90~95%RH, 500+12/-0hrs				
IR : 500Mohm or 12.5Mohm × μF Whichever is smaller				
High Temperature Capacitance change: within ±12.5% With 150% of the rated voltage				
Resistance Tan δ : 0.125 max Max. operating temperature				
IR: 1,000Mohm or 25Mohm × \(\mu^F \) Whichever is smaller				
Temperature Capacitance change: within ±7.5% 1 cycle condition				
	→ 25 °C			
→ Max. operating temperature →	→ 25°C			
5 cycle test				

^{**} The reliability test condition can be replaced by the corresponding accelerated test condition.

D. Recommended Soldering method :

Reflow (Reflow Peak Temperature : 260±5°C, 30sec.)



Product specifications included in the specifications are effective as of March 1, 2013.

Please be advised that they are standard product specifications for reference only.

We may change, modify or discontinue the product specifications without notice at any time.

So, you need to approve the product specifications before placing an order.

Should you have any question regarding the product specifications,

please contact our sales personnel or application engineers.